

FDMA7672-VB Datasheet N-Channel 30-V (D-S) MOSFET

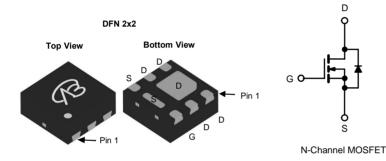
PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)			
30	0.017at V _{GS} = 10 V	10	7.2 nC			
- 50	0.021 at V _{GS} = 4.5 V	8	7.2110			

FEATURES

- Halogen-free
- TrenchFET[®] Power MOSFET
- Optimized for High-Side Synchronous Rectifier Operation
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- Notebook CPU Core
- High-Side Switch



Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30	V		
Gate-Source Voltage		V _{GS}			± 20
	T _C = 25 °C		10		
Continuous Drain Current ($T_1 = 150 \text{ °C}$)	T _C = 70 °C	1-	7		
Continuous Drain Current (1) = 150°C)	T _A = 25 °C	I _D	9 ^{b, c}		
	T _A = 70 °C		6.3 ^{b, c}	^	
Pulsed Drain Current		I _{DM}	30	A	
Continuous Source-Drain Diode Current	T _C = 25 °C	1-	3.7		
Commuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.0 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	20		
Avalanche Energy		E _{AS}	21	mJ	
	T _C = 25 °C		4.1		
Movimum Dower Dissinction	T _C = 70 °C	PD	2.5	w	
Maximum Power Dissipation	T _A = 25 °C	' D	2.2 ^{b, c}	VV	
	T _A = 70 °C		1.3 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS								
Parameter		Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	39	55	°C/W			
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	25	29	0/11			

Notes:

b. Surface Mounted on 1" x 1" FR4 board.
c. t = 10 s.

d. Maximum under Steady State conditions is 85 °C/W.

a. Base on T_C = 25 °C.



SPECIFICATIONS $T_J = 25 \ ^{\circ}C$, unless oth	erwise noted					
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			-	_	_		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_{D} = 250 \mu A$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	I _D = 250 μA		26		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = 200 μΛ		- 6		IIIV/ C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$		1.5		V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zara Cata Valtaga Drain Current	lana	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5$ V, V_{GS} = 10 V	20			А	
	Р	V _{GS} = 10 V, I _D = 10 A		0.017		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 9 \text{ A}$		0.021			
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 10 A		50		S	
Dynamic ^b							
Input Capacitance	C _{iss}			900		pF	
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		165			
Reverse Transfer Capacitance	C _{rss}			73			
		V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A		15	23	nC	
Total Gate Charge	Qg			6.8	10.2		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 10 \text{ A}$		2.5			
Gate-Drain Charge	Q _{gd}			2.3		-	
Gate Resistance	R _g	f = 1 MHz	0.36	1.8	3.6	Ω	
Turn-On Delay Time	t _{d(on)}			16	23	-	
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.4 Ω		12	16		
Turn-Off Delay Time	t _{d(off)}	${\sf I}_{\sf D}\cong$ 9 A, ${\sf V}_{\sf GEN}$ = 4.5 V, ${\sf R}_{\sf g}$ = 1 Ω		16	22		
Fall Time	t _f			10	18		
Turn-On Delay Time	t _{d(on)}			8	16	- ns - -	
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.4 Ω		10	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 9 \text{ A}, V_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega$		16	22		
Fall Time	t _f			8	15		
Drain-Source Body Diode Characterist	tics				1		
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			10		
Pulse Diode Forward Current ^a	I _{SM}				30	A	
Body Diode Voltage	V _{SD}	I _S = 9 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			15	30	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			6	12	nC	
Reverse Recovery Fall Time	t _a	$I_F = 9 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 \text{ °C}$		8		1	
Reverse Recovery Rise Time	t _b			7		ns	

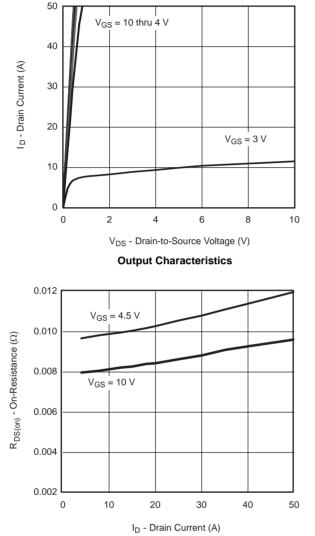
Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

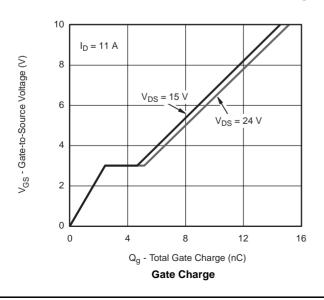
b. Guaranteed by design, not subject to production testing.

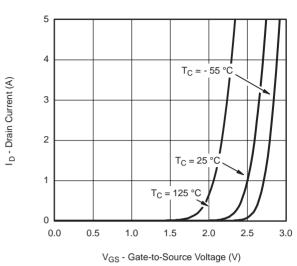
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



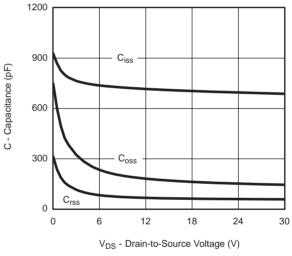


On-Resistance vs. Drain Current and Gate Voltage

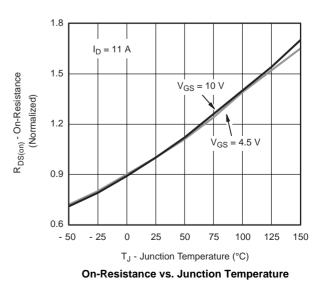




Transfer Characteristics

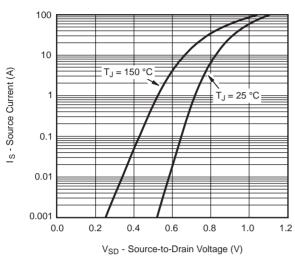


Capacitance

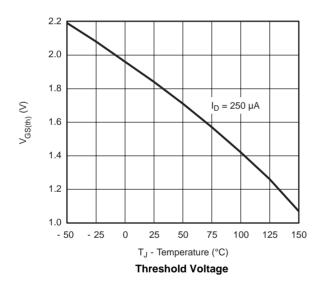


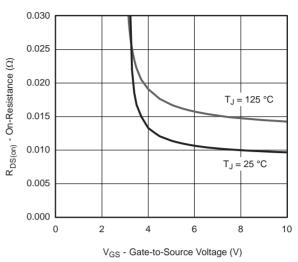
服务热线:400-655-8788



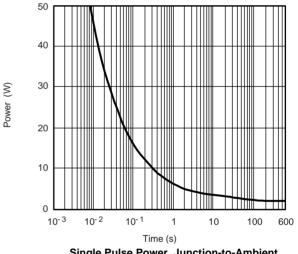




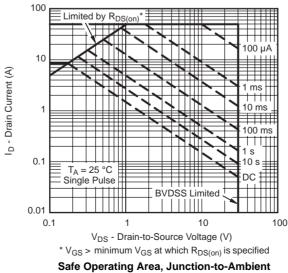




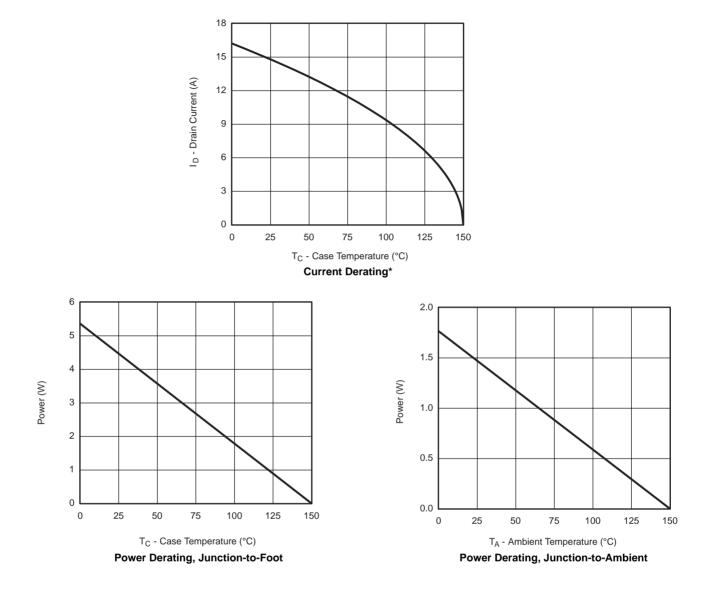
On-Resistance vs. Gate-to-Source Voltage





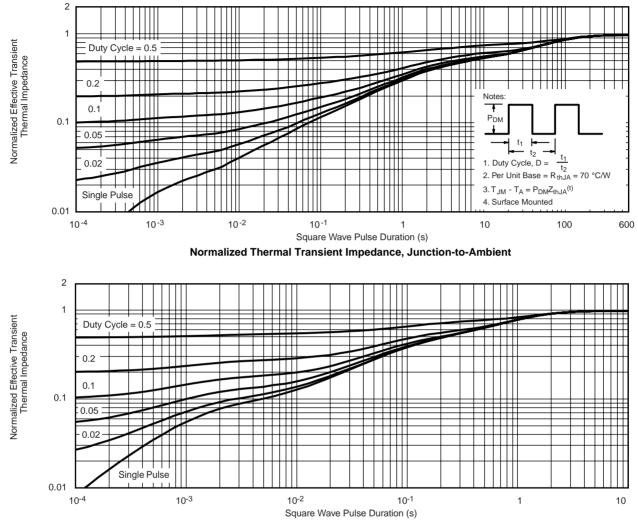






* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

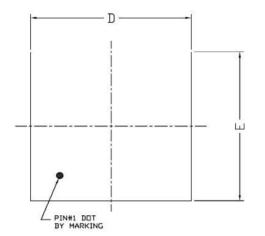


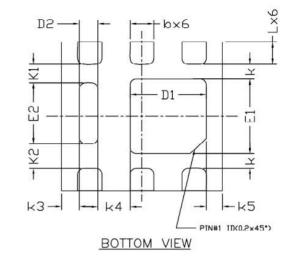


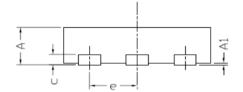
Normalized Thermal Transient Impedance, Junction-to-Foot



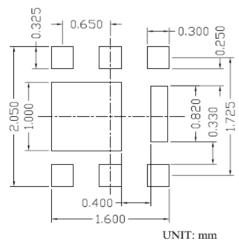








RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
SIMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.50	0.55	0.60	0.020	0.022	0.024	
A1	0.00		0.05	0.000		0.002	
b	0.25	0.30	0.35	0.010	0.012	0.014	
с	0.152 REF				0.006 REF		
D	1.90	2.00	2.10	0.075	0.079	0.083	
D1	0.85	0.95	1.05	0.033	0.037	0.041	
D2	0.13	0.23	0.33	0.005	0.009	0.013	
E	1.90	2.00	2.10	0.075	0.079	0.083	
E1	0.90	1.00	1.10	0.035	0.039	0.043	
E2	0.72	0.82	0.92	0.028	0.032	0.036	
e		0.65 BSC		0.026 BSC			
K	0.20 BSC			0.008 BSC			
K1	0.25 BSC			0.010 BSC			
K2	0.33 BSC			0.013 BSC			
K3	0.22 BSC			0.009 BSC			
K4	0.40 BSC			0.016 BSC			
K5	0.20 BSC			0.008 BSC			
L	0.25	0.30	0.35	0.010	0.012	0.014	

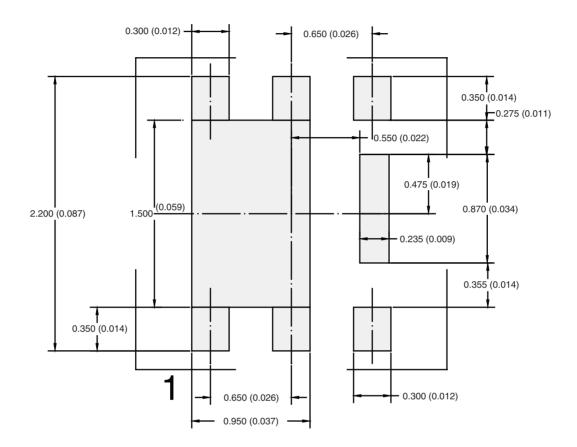
NOTE

1. CONTROLLING DIMENSION IS MILLIMETER.

CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



RECOMMENDED PAD LAYOUT FOR DFN2X2



Dimensions in mm/(Inches)



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